


<b>Search Notes</b> 	<b>Application/Control No.</b> 10535492	<b>Applicant(s)/Patent Under Reexamination</b> CHOI ET AL.
	<b>Examiner</b> Goetze, Simon A	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
455	432.1	1/19/2007	SAG
455	432.3	1/19/2007	SAG
455	435.1	1/19/2007	SAG
455	444	1/19/2007	SAG
455	456.6	1/19/2007	SAG
455	552.1	1/19/2007	SAG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST image and keyword search (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	1/19/2007	SAG
Consulted with Nick Corsaro.	1/19/2007	SAG
Updated previous search.	1/19/2007	SAG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner